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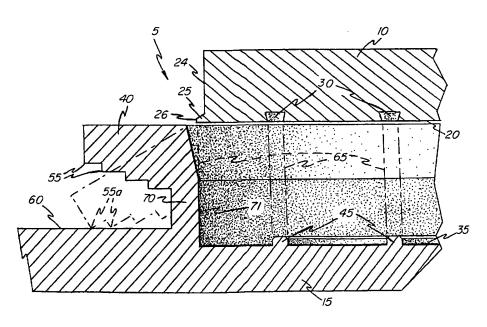
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(54) Title: LOW TEMPERATURE SPUTTER TARGET/BACKING PLATE JOINING TECHNIQUE AND ASSEMBLIES MADE THEREBY



(57) Abstract: The present invention pertains to low temperature sputter target/backing plate (10, 15) joining techniques and assemblies made thereby. More specifically, the joining techniques incorporate a mechanical bond between the corresponding target material (10) and backing plate material (15) around the periphery thereof. The resulting target assemblies are free of welding and other high temperature joining.



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CLAIMS

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- 1. A method of manufacturing a sputter target assembly including a target material with mating surface and a backing plate material with mating surface, comprising:
- a) forming a lip in one of said materials and a clamp in the other
 of said materials; and
 - b) low temperature pressure consolidating said materials such that said lip and said clamp form a mechanical bond.
 - 2. Method as recited in claim 1 further comprising step:
 - c) machining said target assembly to remove excess material.
 - 3. Method as recited in claim 1 wherein said target comprises Al, Cu, Ti, Co or their alloys.
 - 4. Method as recited in claim 1 wherein said backing plate comprises Al, stainless steel, Cu, Ti or their alloys.
 - 5. Method as recited in claim 1 wherein said target comprises Ti.
 - 6. Method as recited in claim 1 wherein said step b) comprises pressure consolidating said assembly at about room temperature.
 - 7. Method as recited in claim 1 wherein said low temperature is a temperature of less than 50% of the melting temperature of the lower melting member of the target and backing plate.
 - 8. Method as recited in claim 1 wherein said low temperature is less than about 100°C.
 - 9. Method as recited in claim 1 wherein said low temperature is less than about 38°C.

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- 10. Method as recited in claim 1 wherein said low temperature is about room temperature.
- 11. A method of manufacturing a sputter target assembly including a target material with mating surface and a backing plate material with mating surface, comprising:
- a) forming a lip in one of said materials and a clamp in the other
 5 of said materials;
 - b) forming protruding portions extending from one of said surfaces; and
- c) low temperature pressure consolidating said materials such that said lip and said clamp form a mechanical bond and said protruding portions
 form a mechanical interlock.
 - 12. Method as in claim 12 further comprising step:
 - d) machining said target assembly to remove excess material.
 - 13. Method as in claim 12 wherein step b) further comprises forming grooves in the other of said surfaces corresponding with said protruding portions.
 - 14. A target assembly made by any one of the preceding claims.
 - 15. A target assembly comprising:
 a target material joined to a backing plate material with a mechanical bond extending around a periphery thereof.
 - 16. A target assembly as in claim 15 further comprising a mechanical interlock joining said target material to said backing plate material.
 - 17. A target assembly as in claim 15 wherein said target material is Ti.

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18. is Al.	A target assembly as in claim 15 wherein said backing plate material
19. is Al.	A target assembly as in claim 17 wherein said backing plate material

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